

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/829,136	CHOE ET AL.	
Examiner		Art Unit	Rakesh K. Dhingra	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0054647	03-2003	Suemasa et al.	438/689
*	B	US-2003/0094239	05-2003	Quon et al.	156/345.51
*	C	US-6,309,978	10-2001	Donohoe et al.	438/710
*	D	US-6,861,373	03-2005	Aoki et al.	438/761
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002246368 A	08-2002	Japan	SNIL, WIKURAMANAYAKA	H01L 21/3065
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.